

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/630,441 HODGES ET AL.	
		Examiner	Art Unit	Page 1 of 1 Kaj K Olsen

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,529,676	06-1996	Maley et al.	204/409
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	P					
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	R					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Allen et al, J. Electroanal. Chem., 178 (1984), pp. 69-86.
	V	Schlereth et al, Electroanalysis, 7(1) (1995), pp. 46-54.
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.